

Notice of References Cited

Application/Control No.

10/509,662

Applicant(s)/Patent Under
Reexamination
SUGAWARA ET AL.

Examiner

Cheung Lee

Art Unit

2812

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,136,654	10-2000	Kraft et al.	438/287
	B	US-			
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	D	US-			
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	F	US-			
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	I	US-			
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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